# Enhancing Approximate Conformance Checking Accuracy with Hierarchical Clustering Model Behaviour Sampling

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### Abstract

Conformance checking techniques evaluate how well a process model aligns with an actual event log. Existing methods, which rely on optimal trace alignment, are computationally intensive. To improve efficiency, a model sampling method has been proposed to construct model behaviour subset that represents the entire model. However, current model sampling techniques often lack sufficient model representativeness, limiting their potential to achieve optimal approximation accuracy. This paper proposes new model behaviour sampling approaches using hierarchical clustering to compute an approximation closer to the exact result. First, we employ the proposed distance criterion to group similar traces. Then, we traverse each cluster and apply two methods (i.e., in-cluster frequency and in-cluster medoid) to identify representative traces, creating a set of candidate traces. Finally, optimal alignment techniques are applied to construct a behavioral subset of the model, which is then aligned with the complete event log to compute approximate conformance and determine its upper and lower bounds. This paper also refines existing upper bound algorithm for better approximation. Our experiments on six real-world event logs demonstrates that our method improves approximation accuracy compared to state-of-the-art model sampling methods.

Keywords: approximate conformance checking, model behaviour sampling, hierarchical clustering, process mining

# 1. INTRODUCTION

Conformance checking is a set of process mining functionalities aimed at identifying deviations between the actual behaviour of the event log ("as-is") and the modeled behaviour of the process model ("to-be"). It facilitates further applications, such as model repair, anomaly detection, and algorithm evaluation [1].

In recent years, alignment-based method [2] has become the de facto standard for conformance checking in computing conformance diagnostics, as it always returns the most accurate deviations, known as optimal-alignment [3]. However, finding the optimal alignment is an NP-hard problem [4]. As the complexity of the log and model increases, the runtime complexity of optimal alignment computation grows exponentially, leading to extremely long computation times—sometimes even taking several weeks. This makes them impractical for real-world applications, especially for large-scale event logs. Moreover, in certain cases, an exact conformance value is not necessary, such as when conducting a preliminary evaluation of process models with various process discovery algorithm [5].

To tackle the problems, various approximation strategies have been proposed, including optimizing the search algorithm [6, 7] and decomposition schemes [8, 9]. However, sampling provides another angle for approximate conformance checking, such as sampling traces to represent event log [10, 11] or selecting model traces to substitute process model [5, 12]. In this paper, we adopt the latter approach, focusing on model sampling. Two main model sampling methods exist: simulation [13] and candidate selection [5]. We concentrate on candidate selection due to its higher accuracy [5]. The candidate selection method identifies representative traces from the event log (i.e. log behaviour subset), and then computes their optimal alignments to determine the corresponding model traces (i.e., model behaviour subset). The accuracy of this approximation depends on the quality of the selected log traces [12]. However, existing log selection techniques (e.g., random, frequency-based [5], K-Medoids [14]) often lack behavioural diversity and model representativeness (see Section 2), leading to reduced accuracy in conformance approximation. Hence, there is significant potential for improving the quality of model behaviour subsets.

In this paper, we propose an enhanced model behaviour sampling method to select more representative subsets and get more accuracy approximate values. First, we apply hierarchical clustering to the event log using our proposed distance criterion. Then, we propose two in-cluster methods to select typical traces from each cluster, which are then used to construct more representative model behaviour subsets. Finally, we extend existing cost lower bound algorithm to achieve more accurate approximation results. The experimental results show that our approach yields more accurate approximations than existing baselines, though with increased approximation time.

The remainder of this paper is organized as follows: Section 2 provides a motivating example to further illustrate the research problem. Section 3 discusses related work in approximate conformance checking. Section 4 outlines the necessary preliminaries. In Section 5, we propose our method for constructing model behaviour subsets using hierarchical clustering. Section 6 details the evaluation and its results. Finally, Section 7 concludes the paper and presents the future work.

# 2. MOTIVATING EXAMPLE

Research such as [5] and [15] has shown that selecting more typical log traces lead to higher approximation accuracy. Thus, the key challenge is determining which subset should be selected to improve approximate accuracy. Existing log selection methods, such as the frequency-based and K-medoids approaches, sometimes lack sufficient log representativeness.

To illustrate the potential limitations of these methods, we use a synthesized event log L. It contains 5,106 traces consisting of 32,600 events and 12 trace variants, as shown in Table 1.

Trace Variant	Freq	ID	Trace Variant	Freq
$\langle a, b, c, d, f, e, g, h \rangle$	1280	6	$\langle a, d, f, h \rangle$	250
$\langle a, b, c, d, e, f, g, h \rangle$	912	7	$\langle a, f, b, c \rangle$	96
$\langle a, b, c, d, e, g, f, h \rangle$	864	8	$\langle a, c, e, f, g \rangle$	64
$\langle a, b, c, h \rangle$	792	9	$\langle a, d, e, g, h \rangle$	56
$\langle a, b, c, d, h \rangle$	400	10	$\langle a, b, f, e, g, h \rangle$	48
$\langle a,h \rangle$	320	11	$\langle b, f, g \rangle$	24
	$ \begin{array}{l} \langle a,b,c,d,f,e,g,h \rangle \\ \langle a,b,c,d,e,f,g,h \rangle \\ \langle a,b,c,d,e,g,f,h \rangle \\ \langle a,b,c,h \rangle \\ \langle a,b,c,d,h \rangle \end{array} $	$ \begin{array}{c c} \langle a,b,c,d,f,e,g,h \rangle & 1280 \\ \langle a,b,c,d,e,f,g,h \rangle & 912 \\ \langle a,b,c,d,e,g,f,h \rangle & 864 \\ \langle a,b,c,h \rangle & 792 \\ \langle a,b,c,d,h \rangle & 400 \end{array} $	$ \begin{array}{c c} \langle a,b,c,d,f,e,g,h \rangle & 1280 & 6 \\ \langle a,b,c,d,e,f,g,h \rangle & 912 & 7 \\ \langle a,b,c,d,e,g,f,h \rangle & 864 & 8 \\ \langle a,b,c,h \rangle & 792 & 9 \\ \langle a,b,c,d,h \rangle & 400 & 10 \end{array} $	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $

To discover the event log presented in Figure 1, we applied the Inductive Miner algorithm [16] with infrequent thresholds of 0.9.

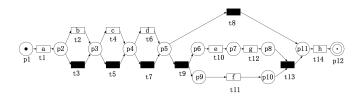


Figure 1: The Process Model discovered by Inductive Miner with infrequent threshold equals to 0.9.

Assuming we select three variants to represent the event log, i.e., the behavior subset consists of three variants. Table 2 shows the behaviour subsets generated by the frequency-based method, K-Medoids, and our proposed methods (see Section 5 for details). The frequency-based subsets shows two key limitations:

- 1. Overestimation of Alignment Cost: Variant 5,  $\langle a, h \rangle$ , can be perfectly replayed in the model with an alignment cost of 0. But it's not included in our model behaviour subset, aligning it would require at least 6 insertions (i.e., cost of 6), resulting in an overestimated approximate cost.
- 2. Lack of Structural Diversity: The selected model traces  $\langle a, b, c, d, f, e, g, h \rangle$  and  $\langle a, b, c, d, e, f, g, h \rangle$  differ only in the order of *e* and *f*. This means they represent essentially the similar structural path, potentially overlooking other important paths in the process model.

Also, the K-Medoids method has drawbacks: it clusters traces solely based on their control-flow information, i.e., syntactic difference. For example, the trace  $\langle b, f, g \rangle$  in log behaviour subset (as shown in Table 2) may have significantly syntactic differences from other traces but, due to its low frequency (only 24 occurrences), it is still not enough to represent the model behaviour.

To address the issues, our approach proposed in Section 5 effectively balances frequency and control-flow information. Table 2 also shows the cost deviation. It refers to the difference in alignment cost between using model behaviour subset and optimal-alignment. The values indicate that the model behaviours generated by our methods significantly reduce the cost deviations compared to vanilla methods.

Table 2:	behaviour	subsets	constructed	by	/ four	methods

Method	Subset	Result	Cost Deviation			
Frequency-	Log Behaviour	$\Sigma_{L} = \{ \langle a, b, c, d, f, e, g, h \rangle, \langle a, b, c, d, e, f, g, h \rangle, \\ \langle a, b, c, d, e, g, f, h \rangle \}$	7907			
based	Model Behaviour	$\begin{split} \Sigma_{M} = \{ \langle a, b, c, d, f, e, g, h \rangle, \langle a, b, c, d, e, f, g, h \rangle, \\ \langle a, b, c, d, e, g, f, h \rangle \} \end{split}$	7806			
K-Medoids	Log Behaviour	Log Behaviour $\Sigma_L = \{\langle a, h \rangle, \langle a, b, c, d, e, g, f, h \rangle, \\ \langle b, f, g \rangle\}$				
K-Weddids	Model Behaviour	$\begin{split} \Sigma_M = \{ \langle a, h \rangle, \langle a, b, c, d, e, g, f, h \rangle, \\ \langle a, b, e, f, g, h \rangle \} \end{split}$	6596			
In-cluster	Log Behaviour	$\label{eq:LogBehaviour} Log Behaviour  \Sigma_L = \{ \langle a, h \rangle, \langle a, b, c, d, f, e, g, h \rangle, \langle a, b, c, h \rangle \}$				
frequency	Model Behaviour	$\Sigma_{M} = \{ \langle a, h \rangle, \langle a, b, c, d, f, e, g, h \rangle \\ \langle a, b, c, h \rangle \}$	4698			
In-cluster medoid	Log Behaviour	4854				
	Model Behaviour	$\Sigma_{M} = \{ \langle a, d, h \rangle, \langle a, b, c, d, f, e, g, h \rangle \\ \langle a, b, c, h \rangle \}$				

# 3. RELATED WORK

To cope with the complexity of alignment construction, approximation techniques have been developed to balance result quality and computational cost. One approach explores fast heuristic search algorithms as alternatives to the A\* algorithm [7, 17, 18]. replace the A\* algorithm by exploring new fast heuristic search algorithms. One such method is Taymouri and Carmona [17], introducing an evolutionary algorithm to enhance alignment approximations. Another scheme involves decomposing models into smaller, more manageable parts, even though this may not always result in optimal alignments [19, 20]. A similar decomposition technique is discussed in [21], though it is restricted to sound and safe workflow nets. Furthermore, building automata capable of aligning log and model has been explored as another technique [22, 23]. This approach provides good approximations of the optimal alignments in most cases.

Reducing the behaviour size is another strategy for approximate conformance checking. One sampling approach focuses on sampling event log. For instance, [24] proposes a trace sampling method, assuming that a few log traces can estimate the conformance value. However, it lacks upper and lower bounds for the approximation and performs worse when the event log contains many unique behaviors.

Another sampling approach targets model behaviour. [5] introduced a model sampling method to construct subsets of model behaviour that represent the whole process model, significantly reducing approximation time while largely maintaining accuracy. The method also provides upper and lower bounds to give some certainty of the approximation. Hierarchical clustering is widely used in process mining for its structural representativeness [25]. Additionally, [26] demonstrates how hierarchical clustering aids in discovering a better model.

### 4. PRELIMINARIES

This section presents conformance checking terminology and notations to support the subsequent sections. We use the basic definitions of Petri net, e.g., labeled Petri Net in [27].

Given a system net SN,  $\phi_f(SN)$  is the set of all complete firing sequences of SN and  $\phi_v(SN)$  is the set of all possible visible traces, i.e., complete firing sequences starting in its initial marking and ending in its final marking projected onto the set of observable activities (not silent transitions e.g.,  $t_3$  in Figure 1).

To measure how a trace aligns to a process model, moves are represented by pairs (a, t), where a is a log activity and t is a model transition. Legal moves can be: *log moves*, *model moves*, or *synchronous moves*. Any other combination is an *illegal move*.

**Definition 1.** (*Alignment*). Let  $\sigma_L \in L$  represent a log trace and  $\sigma_M \in \phi_f(SN)$  denote a complete firing sequence of a system net SN.  $A_{LM}$  is the set of legal moves. An alignment of  $\sigma_L$  and  $\sigma_M$  is a sequence of pairs  $\gamma \in A^*_{LM}$  such that the projection on the first element (ignoring  $\gg$ ) yields  $\sigma_L$  and the projection on the second element (ignoring  $\gg$  and transition labels) yields  $\sigma_M$ .

To quantify the costs of alignments we introduce a cost function  $\delta$  in Definition 2.

**Definition 2.** (*Cost of Alignment*). Cost function  $\delta \in A_{LM} \to \mathbb{N}$  assigns costs to legal moves. The cost of an alignment  $\gamma \in A_{LM}^*$  is the sum of all costs:

$$\delta(\gamma) = \sum_{(a,t)\in\gamma} \delta(a,t)$$

The cost values assigned to log moves, model moves, and synchronous moves are 1, 1, and 0, respectively. Note that an alignment is considered optimal if it has the minimum alignment cost.

**Definition 3.** (*Optimal Alignment*). Let *L* be an event log and *SN* a system net where  $\phi_v(SN) \neq \emptyset$ .

- For  $\sigma_L \in L$ , we define:  $\Gamma_{\sigma_L,SN} \in \{\gamma \in A^*_{LM} \mid \exists \sigma_M \in \phi_f(SN) \text{ is an alignment of } \sigma_L \text{ and } \sigma_M \}.$
- An alignment  $\gamma \in \Gamma_{\sigma_L,SN}$  is optimal for trace  $\sigma_L \in L$  and system net SN if for any alignment  $\gamma' \in \Gamma_{\sigma_L,M}$ :  $\delta(\gamma') \geq \delta(\gamma)$ .
- $\gamma_{SN} \in A_{LM}^* \to A_{LM}^*$  is a mapping that assigns any log trace  $\sigma_L$  to an optimal alignment, i.e.,  $\gamma_{SN}(\sigma_L) \in \Gamma_{\sigma_L,SN}$  and  $\gamma_{SN}(\sigma_L)$  is an optimal alignment.

**Definition 4.** (*Levenshtein Edit Distance*). As defined by [28], the Levenshtein edit distance  $d(\sigma_1, \sigma_2) \rightarrow \mathbb{N}$  represents the minimum number of edit operations (i.e., insertions, deletions, and

substitutions) required to transform one sequence into another. For instance,  $d(\langle a, b \rangle, \langle c, d \rangle) = 2$ , where the two edit operations are substitutions (a, c) and (b, d).

**Definition 5.** (*Edit Distance Cost Function*). We can calculate the distance between two traces (or sequences) faster by using a modified version of the Levenshtein edit distance [29]. Let  $\sigma_1, \sigma_2 \in A^*$  be two sequences of activities. The Edit Distance Cost Function  $\Delta(\sigma_1, \sigma_2) \rightarrow \mathbb{N}$  is defined as the minimum number of edits (insertion or deletion of activities) required to transform  $\sigma_1$  into  $\sigma_2$ .

Suppose that *S* is a set of sequences,  $\Phi(\sigma_L, S) = \min_{\sigma_M \in S} \Delta(\sigma_L, \sigma_M)$  returns the distance of the most similar sequence in *S*. Let  $\phi_v(SN)$  be the set of all visible firing sequences in *SN*, and  $\gamma_{SN}(\sigma)$  be an optimal alignment for sequence  $\sigma$ . It is possible to prove that  $\delta_S(\gamma_{SN}(\sigma)) = \Phi(\sigma, \phi_v(SN))[12]$ .

In the context of alignment, the edit distance function can be used as a cost function  $\delta_S$  for evaluating the misalignment between a log trace  $\sigma_L$  and a model trace  $\sigma_M$ . This cost function assigns a value corresponding to the number of operations required to align the two sequences. For example,  $\Delta(\langle a, c, b, e, d \rangle, \langle a, b, c, a, d \rangle) = 4$  corresponds to two deletions and two insertions.

Moreover, the alignment cost of a single trace can be converted into a fitness value between 0 (poor fitness, i.e., maximal costs) and 1 (perfect fitness, i.e., zero costs) using Equation 1 [5]. In this regard, we normalize this cost relative to the worst case, with one log move for each activity in the trace and one model move for each transition in the model's shortest path,  $SPM = \min_{\sigma_M \in \phi_f}(|\sigma_M|)$ . Here, the optimal alignment cost,  $\delta(\gamma_{SN}(\sigma))$ , can be replaced by an alternative cost (e.g., edit distance cost) to obtain a corresponding fitness value.

$$Fitness_{\text{Trace}}(\sigma_L, SN) = 1 - \frac{\delta_S(\gamma_{SN}(\sigma))}{|\sigma_L| + SPM}$$
(1)

Note that the overall fitness between the event log and the system net is the weighted average of single trace fitness values.

# 5. APPROACH

In this section, we present the proposed conformance approximation method. An overview of our approach is shown in Figure 2. The method begins with a preprocessing stage using hierarchical clustering techniques. Next, two methods are proposed for constructing model behaviour subsets: in-cluster frequency and in-cluster medoid methods. Finally, the alignment approximation process is explained.

# 5.1. Preprocess event log using hierarchical clustering

In this stage, we apply agglomerative hierarchical clustering [30] on event logs. Specifically, we first partition the event log based on trace variants to get the trace variant subset  $\Sigma_{\sigma_v}$ . Then, we introduce normalized weighted Levenshtein distance to measure the distance between these variants(see Definition 6) as a new in-cluster distance criterion. This criterion considers both frequency and control-flow information, alleviating the problem

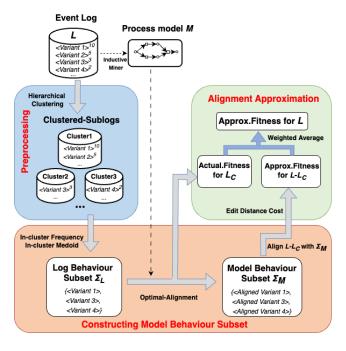


Figure 2: Overview of our approach

with current log selection methods mentioned in Section 2. It is used to build a distance matrix, then forming a dendrogram. By cutting-off the dendrogram, we obtain the desired number of clusters. The framework is illustrated in Figure 3.

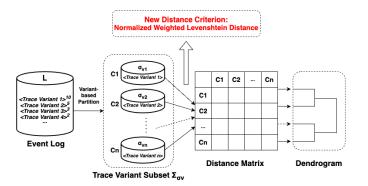


Figure 3: Preprocessing workflow for hierarchical clustering

**Definition 6.** (*Normalized Weighted Levenshtein Distance*). Let  $A^*$  be the set of all possible sequences of activities in A, and let  $\sigma_{v1}, \sigma_{v2}$  be two trace variants  $\in A^*$ . The normalized weighted Levenshtein distance between  $\sigma_{v1}$  and  $\sigma_{v2}$ , where each trace variant has a frequency  $f(\sigma_{v1})$  and  $f(\sigma_{v2})$ , is defined as:

$$d_{weighted}(\sigma_{v1}, \sigma_{v2}) = \frac{f(\sigma_{v1}) \cdot f(\sigma_{v2}) \cdot d_N(\sigma_{v1}, \sigma_{v2})}{\max\{f(\sigma_{v1})^2, f(\sigma_{v2})^2\}}$$
(2)

where the normalized Levenshtein distance  $d_N(\sigma_{v1}, \sigma_{v2})$  is given by:

$$d_N(\sigma_{\nu_1}, \sigma_{\nu_2}) = \frac{d(\sigma_{\nu_1}, \sigma_{\nu_2})}{\max\{|\sigma_{\nu_1}|, |\sigma_{\nu_2}|\}}$$
(3)

*Here*,  $d_N(\sigma_{v1}, \sigma_{v2}) = 0$  means the two traces are exactly the

same, and  $d_N(\sigma_{v1}, \sigma_{v2}) = 1$  means the two traces are completely different.

**Definition 7.** (*Distance Matrix*). Let  $\sigma_{v1}, \sigma_{v2}, \ldots, \sigma_{vi} \in A^*$ represent all trace variants in event log L. The matrix D(L) is defined as, :

$$D(L) = \begin{bmatrix} 0 & d(\sigma_{v1}, \sigma_{v2}) & \cdots & d(\sigma_{v1}, \sigma_{vi}) \\ d(\sigma_{v2}, \sigma_{v1}) & 0 & \cdots & d(\sigma_{v2}, \sigma_{vi}) \\ \vdots & \vdots & \ddots & \vdots \\ d(\sigma_{vi}, \sigma_{v1}) & d(\sigma_{vi}, \sigma_{v2}) & \cdots & 0 \end{bmatrix}$$
(4)

where *d* is the normalized weighted Levenshtein distance function.

#### 5.2. Constructing Model Behaviour

In this stage, we first propose two in-cluster methods to get log behaviour subset  $\Sigma_L$  from the generated clusters, and transform it to model behaviour subset  $\Sigma_M$ . Specifically,

a) Candidate selection: After preprocessing, we obtain several clusters, each representing different behaviours within the model. The following question is how to choose the typical traces from each cluster to construct a better log behaviour subset. We extend the ideas of frequency-based and medoid methods by introducing two in-cluster methods, i.e., in-cluster frequency and in-cluster medoid methods, to select trace that represents typical behaviour in each cluster as our candidate. The in-cluster frequency method selects the most frequent trace variant from each cluster. The in-cluster medoid method computes the pairwise Levenshtein distances between all traces in each cluster, then construct a distance matrix and obtain the medoid trace (see Definition 8). Note that the medoid trace is the one with the smallest total distance to all other traces in the cluster.

**b)** Optimal-alignment: In this step, we align  $\Sigma_L$  with process model to construct the  $\Sigma_M$ , that is, we compute the optimal alignments of selected traces in the event log and finding the corresponding model traces for these alignments.

Table 3 shows three clusters generated from the event log in Table 1. For example, applying the in-cluster frequency method to cluster 2 yields  $\langle a, b, c, h \rangle^{792}$ , the most frequent trace. Repeating this for each cluster, we obtain  $\Sigma_L =$  $\{\langle a, b, c, d, f, e, g, h \rangle^{1280}, \langle a, b, c, h \rangle^{792}, \langle a, h \rangle^{320}\}$ . We then align  $\Sigma_L$  with the process model as shown in Figure 1, resulting in  $\Sigma_M$ .Note that  $\Sigma_L$  and  $\Sigma_M$  are same in this example, as all traces can be fully replayed in the model.

Table 3: The clusters generated from the example log provided in Table 1

Cluster ID	Traces in each cluster
1	$\{\langle a,b,c,d,f,e,g,h\rangle^{1280},\langle a,b,c,d,e,f,g,h\rangle^{912},\langle a,b,c,d,e,f,g,h\rangle^{864}\}$
2	$\{\langle a,b,c,h\rangle^{792},\langle a,b,c,d,h\rangle^{400},\langle a,f,b,c\rangle^{96}\}$
3	$\begin{aligned} & \{\langle a,h\rangle^{320},\langle a,d,h\rangle^{250},\langle a,c,e,f,g\rangle^{64},\\ & \langle a,d,e,g,h\rangle^{56},\langle a,b,f,e,g,h\rangle^{48},\langle b,f,g\rangle^{24} \} \end{aligned}$

The specific algorithm steps for proposed methods are outlined in Algorithms 1 and 2.

# Algorithm 1 In-cluster Medoid Method

Input: Event log L; Process model M.

- **Output:** Model behaviour subset  $\Sigma_M$ .
- 1: Initialize log behaviour subset:  $\Sigma_L \leftarrow \emptyset$
- 2: Initialize model behaviour subset:  $\Sigma_M \leftarrow \emptyset$
- 3: Partition *L* based on variants into  $\Sigma_{\sigma_v}$
- Cluster Σ<sub>σ<sub>ν</sub></sub> into k clusters {Σ<sub>σ<sub>ν1</sub></sub>, Σ<sub>σ<sub>ν2</sub></sub>,..., Σ<sub>σ<sub>νk</sub></sub>} using hierarchical clustering
- 5: **for** i = 1 to k **do**
- 6: Compute pairwise Levenshtein distances between all variants in  $\Sigma_{\sigma_{vi}}$
- 7: Construct distance matrix  $D(\Sigma_{\sigma_{vi}})$
- 8: Find the medoid trace  $\sigma_L^{(i)}$  in  $\Sigma_{\sigma_{vi}}$ :

$$\sigma_{L}^{(i)} = \arg\min_{\sigma \in \Sigma_{\sigma_{vi}}} \sum_{\sigma' \in \Sigma_{\sigma_{vi}}} d(\sigma, \sigma')$$

- 9: Update log behaviour subset:  $\Sigma_L \leftarrow \Sigma_L \cup \{\sigma_L^{(i)}\}$
- 10: end for
- 11: **for** each  $\sigma_L^{(i)} \in \Sigma_L$  **do**
- 12: Compute optimal alignment  $\gamma_{SN}^{\text{opt}}$  between  $\sigma_L^{(i)}$  and M13: Map to model trace:  $\sigma_M^{(i)} \leftarrow \lambda_{SN}(\sigma_L^{(i)})$
- 14: Update model behaviour subset:  $\Sigma_M \leftarrow \Sigma_M \cup \{\sigma_M^{(i)}\}$
- 15: end for
- 16: return  $\Sigma_M$

# Algorithm 2 In-cluster Frequency Method

**Input:** Event log *L*; Process model *M*.

**Output:** Model behaviour subset  $\Sigma_M$ .

1: Initialize log behaviour subset:  $\Sigma_L \leftarrow \emptyset$ 

- 2: Initialize model behaviour subset:  $\Sigma_M \leftarrow \emptyset$
- 3: Partition *L* based on variants into  $\Sigma_{\sigma_y}$
- 4: Cluster  $\Sigma_{\sigma_{v}}$  into k clusters  $\{\Sigma_{\sigma_{v1}}, \Sigma_{\sigma_{v2}}, \dots, \Sigma_{\sigma_{vk}}\}$  using hierarchical clustering
- 5: **for** i = 1 to k **do**
- 6: Let  $\Sigma_{\sigma_{vi}}$  denote the *i*-th cluster of variants
- 7: Find the most frequent variant  $\sigma_L^{(i)}$  in  $\Sigma_{\sigma_{vi}}$ :

$$\sigma_L^{(i)} = \arg \max_{\sigma \in \Sigma_{\sigma_{vi}}} f(\sigma)$$

- 8: Update log behaviour subset:  $\Sigma_L \leftarrow \Sigma_L \cup \{\sigma_L^{(i)}\}$ 9: end for
- 10: for each  $\sigma_L^{(i)} \in \Sigma_L$  do
- 11: Compute optimal alignment  $\gamma_{SN}^{\text{opt}}$  between  $\sigma_L^{(i)}$  and M
- 12: Map to model trace:  $\sigma_M^{(i)} \leftarrow \lambda_{SN}(\sigma_L^{(i)})$
- 13: Update model behaviour subset:  $\Sigma_M \leftarrow \Sigma_M \cup \{\sigma_M^{(i)}\}$
- 14: **end for**
- 15: return  $\Sigma_M$

**Definition 8.** (*In-cluster Medoid*). Let L' be a clustered sublog, n denote the number of trace variants in L', and D(L') be the distance matrix of L'. The trace  $\sigma_j = \arg \min_{\sigma_j \in L'} \sum_{i \in [1,n]} d(\sigma_i, \sigma_j)$ represents the medoid trace of sublog L'.

#### 5.3. Computing Alignment Approximation

After constructing  $M_B$ , we use it to approximate alignments for the traces in  $L - L_C$ , where  $L_C$  refers to the frequency-based trace variants used to build  $\Sigma_L$ . The actual alignment fitness for the variants in  $\Sigma_L$  has already been computed during the construction of  $M_B$ , so we can directly use this value for more accurate approximations. At this stage, we calculate the alignment approximations for the remaining variants.

Typically, actual fitness is calculated using standard alignment costs. However, for the remaining variants, we use the edit distance cost function  $\Delta$  (see Definition 5) to estimate fitness. This method provides guaranteed upper and lower bounds for the alignment cost, instead of exact values [5] (see Lemma 1 and Lemma 2 below).

$$Fitness(L, SN) = \frac{\sum_{\sigma \in L_{C}} f(\sigma) \times Fitness_{Approximate}(\sigma, SN)}{\sum_{\sigma \in L} f(\sigma)} + \frac{\sum_{\sigma \in L-L_{C}} f(\sigma) \times Fitness_{Actual}(\sigma, SN)}{\sum_{\sigma \in L} f(\sigma)}$$
(5)

**Lemma 1** (Alignment Cost Upper Bound). Let  $\sigma_L \in \mathcal{U}_A^*$  be a log trace and  $\sigma_M \in \phi_v(SN)$  be a visible firing sequence of SN. We have  $\delta_S(\gamma_{SN}(\sigma_L)) \leq \Delta(\sigma_L, \sigma_M)$ , where  $\gamma_{SN}(\sigma_L)$  is the optimal alignment.

*Proof.* The proof is provided in Appendix A.1 and demonstrates how the edit distance guarantees this upper bound.

Simply put, if we align trace variant  $4 \langle a, b, c, d, h \rangle$  from Table 1 with  $\sigma_L$  from the in-cluster frequency subset in Table 2, the alignment cost is 1 (i.e., removing "d"). However, since  $\sigma_M$  is a subset of the full model, the actual cost could be smaller or equal. Thus, we use 1 as the upper bound for this variant.

**Lemma 2** (Alignment Cost Lower Bound). Let  $SPM = \min_{\sigma_M \in \phi_v(SN)} |\sigma_M|$  and  $LPM = \max_{\sigma_M \in \phi_v(SN)} |\sigma_M|$ , representing the shortest and longest paths in the process model M.  $\sigma_L[_{A_v(SN)}$  and  $\kappa(\sigma_L)$  are as defined in Definition 9.

For any log trace  $\sigma_L$ , if  $|\sigma_L[_{A_v(SN)}| < SPM$ , the alignment cost lower bound is  $SPM - |\sigma_L[_{A_v(SN)}| + \kappa(\sigma_L)$ ; if  $|\sigma_L[_{A_v(SN)}| > LPM$ , the lower bound is  $|\sigma_L[_{A_v(SN)}| - LPM + \kappa(\sigma_L)$ ; if  $SPM \le |\sigma_L[_{A_v(SN)}| \le LPM$ , the lower bound is  $\kappa(\sigma_L)$ .

# *Proof.* The proof is provided in Appendix A.2.

The cost lower bound is the minimum edit operations needed to transform  $\sigma_L$  into  $\sigma_M$ . We refine this algorithm using activity projection (see Definition 9) to improve approximation accuracy. Existing methods compare log trace length directly with the model's range, potentially yielding errors if irrelevant activities are present. For instance, in Figure 1, a trace  $\langle a, x \rangle$  might seem aligned if its length falls within the model's shortest (SPM=2) and longest paths (LPM=8), even though x is not in the model, resulting in a miscalculated cost of 0. Our algorithm removes non-model activities (e.g., removing x from  $\langle a, x \rangle$  to form  $\langle a \rangle$ ) before comparing trace lengths. This adjustment yields a more accurate cost of 1 rather than 0, resulting in a smaller upper fitness and tighter bound width.

These bounds are then used to compute corresponding upper and lower fitness bounds (with the cost upper bound giving the fitness lower bound, and vice versa) using Equation 1. The computations for the fitness bounds are provided in Algorithm 3 and 4. The average of these bounds provides the approximate fitness. Once we compute the approximate fitness for each remaining variant, we take the weighted average of these values along with the previously computed actual fitness to get the overall approximate fitness for the entire event log, as shown in Equation 5.

**Definition 9** (Activity Projection). Let  $A_{\nu}(SN)$  be the set of unique observable activities in the system net SN. For any log trace  $\sigma_L$ , let  $\sigma_L[_{A_{\nu}(SN)}$  represent the projection of  $\sigma_L$  onto  $A_{\nu}(SN)$ , meaning the set of activities in  $\sigma_L$  that also appear in the model. Define  $\kappa(\sigma_L) = |\sigma_L| - |\sigma_L[_{A_{\nu}(SN)}|$  as the number of activities in  $\sigma_L$  that are not present in the model.

For example, let  $\sigma_L = \langle a, b, x \rangle$  be a log trace and the observable activities of the system net be  $A_v(SN) = \{a, b, c, d, e\}$ . Projecting  $\sigma_L$  onto  $A_v(SN)$  results in  $\sigma_L \lceil_{A_v(SN)} = \langle a, b \rangle$ , as *x* is not part of  $A_v(SN)$ . Therefore,  $\kappa(\sigma_L) = |\sigma_L| - |\sigma_L \lceil_{A_v(SN)}| = 3-2 = 1$ , indicating one activity in  $\sigma_L$  is not present in the model.

Algorithm 3 Fitness lower bound computation
<b>Input:</b> Event log $L$ ; Optimal-aligned Log $L_C$ ; Model be
haviour subset $\Sigma_M$ .
<b>Output:</b> Lower bound fitness $L_fitness(\sigma_L, M)$ .
1: for each $\sigma_L \in L - L_C$ do
2: $\Phi(\sigma_L, \Sigma_M) //$ Compute minimum edit distance cost
3: $L_{-}fitness(\sigma_{L}, M) \leftarrow 1 - \frac{\Phi(\sigma_{L}, \Sigma_{M})}{ \sigma_{L}  + \min_{\sigma_{M} \in \phi_{V}(SN)}( \sigma_{M} )}$
4: end for
5: return $L_fitness(\sigma_L, M)$

# 6. EVALUATION

In this section, we assess the accuracy and time performance of our proposed log selection methods compared to frequencybased and K-Medoids techniques, and evaluate their differences in accuracy and time against normal alignment. Note that the comparison between model behaviour sampling and other approximate methods has been discussed in [5], we focus here on comparisons with the baselines of model behaviour sampling. First, we briefly describe the implementation (Section 6.1) and experimental setup (Section 6.2), followed by a discussion of the experimental results (Section 6.3).

#### 6.1. Implementation

Our implementation consists of two steps: first, we implemented the algorithms described in Sections 5.1 and 5.2 in

Algorithm 4 Fitness upper bound computation
<b>Input:</b> Event log $L$ ; Optimal-aligned Log $L_C$ ; Model be-
haviour subset $\Sigma_M$ .
<b>Output:</b> Upper bound fitness $U_{-}fitness(\sigma_L, M)$ .
1: $SPM \leftarrow \min_{\sigma_M \in \phi_v(SN)}  \sigma_M  // \text{Shortest path}$
2: $LPM \leftarrow \max_{\sigma_M \in \phi_{\mathcal{V}}(SN)}  \sigma_M  // \text{Longest path}$
3: for each $\sigma_L \in L - L_C$ do
4: Project $\sigma_L$ onto $SN$ : $\sigma_L \lceil_{A_v(SN)}$
5: Compute $\kappa(\sigma_L) =  \sigma_L  -  \sigma_L _{A_{\nu}(SN)} $
6: <b>if</b> $ \sigma_L[_{A_v(SN)}  < SPM$ <b>then</b>
7: $U_{-fitness}(\sigma_L, M) \leftarrow 1 - \frac{SPM -  \sigma_L _{A_V(SN)}  + \kappa(\sigma_L)}{ \sigma_L  + \min_{\sigma_L} e^{-\delta_L(SN)}( \sigma_M )}$
8: else if $ \sigma_L[A_v(SN)  > LPM$ then
9: $U_{-fitness}(\sigma_{L}, M) \leftarrow 1 - \frac{ \sigma_{L}[A_{V}(SN)  - LPM + \kappa(\sigma_{L})]}{ \sigma_{L}  + \min_{\sigma_{M} \in \phi_{V}(SN)}( \sigma_{M} )}$
10: else
11: $U_{-fitness}(\sigma_L, M) \leftarrow 1 - \frac{\kappa(\sigma_L)}{ \sigma_L  + \min_{\sigma_M \in \delta_{\mathcal{D}}(SN)}( \sigma_M )}$
12: end if
13: end for
14: return $U_{-}fitness(\sigma_L, M)$

Python, to generate log behaviour subset from event log. Specifically, we extended the pm4py.algo.clustering package in PM4py [31] by introducing the normalized weighted Levenshtein distance (Definition 6), to perform hierarchical clustering. And implemented two proposed in-cluster methods to get the log behaviour subset based on the clustering result. In the second step, we used an existing plugin in ProM [32], *Conformance Log to Log Approximation* [33], with the generated model behaviour subset and the original event log as input, obtaining approximate fitness bounds and values. For the baselines, we used the implementation proposed by Fanisani [5]. For the normal alignment, we used PM4py to compute the time and fitness values. The source code and experimental results is available on Github <sup>1</sup>.

#### 6.2. Experimental Setup

Our experiments were based on six real event logs, with the basic information about these event logs is given in Table 4. Here, *Uniqueness* refers to  $\frac{Variant#}{Trace#}$ . A *Uniqueness* value close to 1 indicates that almost all traces are different, e.g., *Sepsis*. For process discovery, we used *Inductive Miner infrequent algorithm* [34] with *infrequent thresholds of 0.4* to get the process model . Two log selection methods, *frequency-based sampling, K-Medoids clustering*, were used as baselines to compare with our proposed methods, i.e., *In-cluster frequency method* and *In-cluster medoid method*. Additionally, we set the *selection percentage* to 10%, 20%, 30%, 40%, and 50%, representing the ratio of selected variants to the total number of variants in the event logs. Our experiment was repeated four times since the conformance approximation time is non-deterministic. Finally, we performed the experiments on a computer with Apple M1 (8 cores), 8 GB RAM running macOS.

<sup>&</sup>lt;sup>l</sup>https://github.com/lvy19909/Approximate-Conformance-Che cking-using-Hierarchical-Clustering.git

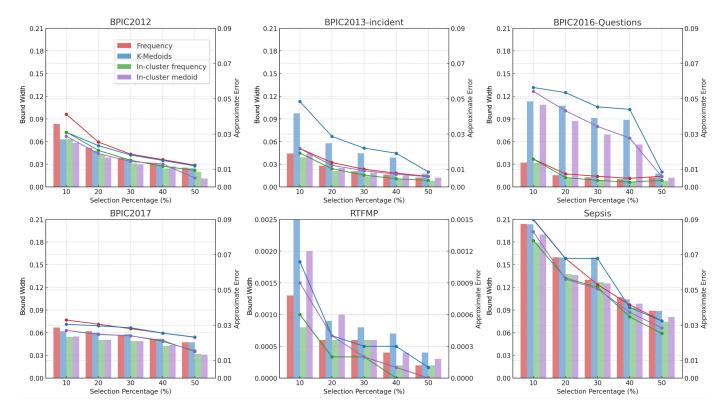


Figure 4: The performance differences of different selection strategies on band width and approximate error.

Table 4: The real-life event logs used	in the experiments
ruble in The rear type event togs used	in the experiments

racie in the rear age event togs abed in the experiments									
Event Log	Activities #	Traces #	Variants #	Uniqueness					
BPIC2012 [35]	25	13087	4366	0.33					
BPIC2013-closed problems [36]	4	1487	183	0.12					
BPIC2016-Questions [37]	8	21533	2261	0.10					
BPIC2017 [38]	28	31509	15930	0.51					
Spesis [39]	18	1050	846	0.81					
RTFMP [40]	13	150370	231	0.01					

# 6.2.1. Evaluation Metrics

To measure approximation accuracy, we used *Approximate* Error, defined as *ApproximateError* = |ActualFitness - ApproximateFitness|, where a value closer to 0 indicates higher accuracy. Additionally, we assess the *Bound Width* as *BoundWidth* =  $U_{-}fitness - L_{-}fitness$ , with a smaller width indicating tighter bounds and a more accurate approximation.

We used  $PI = \frac{Actual Conformance Time}{Approximate Conformance Time}$  to assess time performance. Actual Conformance Time refers to the time needed to compute normal alignment, while Approximate Conformance Time includes the total time for approximation. A PI value greater than 1 indicates the approximation is faster than the actual conformance computation. Preprocessing time (e.g., hierarchical clustering) is included in the approximate conformance time.

### 6.3. Experimental Result and Discussion

Table 5 shows the actual and approximate fitness values generated by comparison methods using 20% of the variants in six event logs, and for each row, we bolded the smallest values. The results show that the proposed in-cluster methods are more accurate than the baselines. Our complete experimental data is provided in Appendix B.

E	A	Approximate Fitness						
Event Log	Actual Fitness	Frequency	K-Medoids	In-cluster frequency	In-cluster medoid			
BPIC2012	0.9995	0.9741	0.9761	0.9788	0.9806			
BPIC2013- closed problems	0.9997	0.9860	0.9711	0.9894	0.9875			
BPIC2016- Questions	0.9997	0.9923	0.9463	0.9944	0.9565			
BPIC2017	0.9995	0.9690	0.9700	0.9749	0.9747			
Road	0.9999	0.9997	0.9996	0.9998	0.9995			
Sepsis	0.9880	0.9202	0.9202	0.9313	0.9319			

Table 5: Approximate fitness comparison for different selection methods

Figure 4 shows that both *Approximate Error* and *Bound Width* decrease as selection percentages increase. Here, *Bound Width* is represented by bars, and *Approximate Error* by lines, illustrating the improvements in these metrics as the selection percentage rises. Our in-cluster methods consistently achieve tighter bounds at each selection percentage. Notably, at a 50% selection on the BPIC2017 log, the bound widths of baseline are around 0.05, while our methods reduce this by 40% to 0.03. Additionally, across all datasets with different selection percentages, the in-cluster frequency method shows an average improvement of 19.1% in *Approximate Error* compared to the frequency-based method, while the in-cluster medoid method achieves an average improvement of 27.6% compared to the K-Medoid method. Moreover, in-cluster frequency method often produces tighter bounds than in-cluster medoid method, especially on low

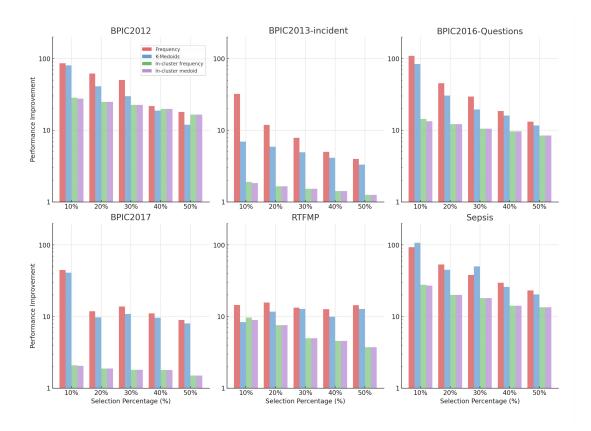


Figure 5: The performance improvement using different methods in six event logs

*Uniqueness* logs like BPIC2016-Questions, where selecting the most frequent trace is more effective than clustering. However, on high *Uniqueness* logs like *Sepsis*, in-cluster medoid method provides more accurate approximations.

In Figure 5, we compare the time performance of different log selection methods and their improvement over normal alignment. Note that a value of 1 represents the normal alignment time. Among the comparison methods, the frequency method usually results in higher performance improvement, followed by the K-Medoids method. Our methods is less efficient compared to them. Since our methods are based on hierarchical clustering, it requires step-by-step merging and calculating all possible cluster combinations, so we need more preprocessing time compared to baselines, which leads to the approximate time is higher, especially on large datasets such as BPIC2013incidents and BPIC2017. However, even with this increase, our method remains significantly faster than the normal alignment approach.

Considering both Figure 4 and Figure 5, we observe a tradeoff between performance and accuracy in the proposed methods. That is, we provide more accurate bounds but need more preprocessing time to approximate the fitness.

# 7. CONCLUSION

In this paper, we propose an enhanced model behaviour sampling method using hierarchical clustering to construct more representative model behaviour subsets. By incorporating both frequency and control-flow information from the event log, our approach more effectively captures the model's behaviour, leading to improved approximation accuracy. Experimental results show that our method produces approximations that are on average over 19.1% closer to the actual alignment values than baseline methods, though it requires more computation time.

In future work, we plan to apply a time-optimized hierarchical clustering algorithm to reduce the approximation time of our method. Additionally, an incremental approximation tool could be developed to increase the size of model behaviour during the time, allowing the user decide when the accuracy is enough. Furthermore, exploring how to make use of the distribution information (e.g., *Uniqueness*) in the event log to choose better approximate method is also a direction for future research.

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#### Appendix A. Proof of Lemmas

# Appendix A.1. Proof of Alignment Cost Upper Bound

*Proof.* We have shown that  $\min_{\sigma_M \in S} \Delta(\sigma_L, \sigma_M) = \delta_S(\gamma_{SN}(\sigma_L))$ in Definition 5, so  $\Delta(\sigma_L, \sigma_M) \ge \delta_S(\gamma_{SN}(\sigma_L))$ . Therefore, if  $\delta_S(\gamma_{SN}(\sigma_L)) > \Delta(\sigma_L, \sigma_M), \gamma_{SN}(\sigma_L)$  is not an optimal alignment. Consequently, for any  $M_B \subseteq \phi_v(SN), \Phi(\sigma_L, M_B)$  returns an upper bound for the cost of optimal alignment [5].

#### Appendix A.2. Proof of Alignment Cost Lower Bound

*Proof.* When  $|\sigma_L[_{A_v(SN)}| < SPM$ , at least  $SPM - |\sigma_L[_{A_v(SN)}|$  insertions are needed. Adding the initial alignment cost, the total minimum alignment cost is  $|SPM - \sigma_L[_{A_v(SN)}| + |\kappa(\sigma_L)|$ . Similarly, when  $|\sigma_L[_{A_v(SN)}| > LPM$ , at least  $|\sigma_L[_{A_v(SN)}| - LPM$  deletions are required. Thus, the total alignment cost is  $|\sigma_L[_{A_v(SN)} - LPM| + |\kappa(\sigma_L)|$ . When  $SPM \le |\sigma_L[_{A_v(SN)}| \le LPM$ , no insertions or deletions are needed, so the alignment cost is  $|\kappa(\sigma_L)|$ .

Appendix B. Original Experimental Data

	Normal Constitution						Approximation Method Baseline In-cluster medoid			
Log	Actual Fitness	Alignment		Candidate Parameter Parameter				In-cluster medold In-cluster In-cluster		
	T functions	Time	rereentage			Frequency	K-Medoids	frequency	medoid	
					Lower Bound	0.9167	0.9371	0.9368	0.9416	
				Approximate fitness	Approximate fitness	0.9583	0.9685	0.9684	0.9708	
					Upper	1.0000	1.0000	1.0000	1.0000	
				Approx	Bound	0.0412	0.0310	0.0311	0.0287	
					ror and					
			10%	Wi	idth	0.0833	0.0629	0.0632	0.0584	
					cessing e (ms)	/	/	1219923	1259201	
					ximate e (ms)	411778	439928	25030	26102	
				Total Ap	proximate	411778	439928	1244953	1285303	
					e (ms) PI	85.9687	80.4677	28.4348	27.5421	
					Lower Bound	0.9482	0.9522	0.9576	0.9612	
				Approximate	Approximate	0.9741	0.9761	0.9788	0.9806	
				fitness	fitness Upper	1.0000	1.0000	1.0000	1.0000	
				Approx	Bound					
				Er	TOP	0.0254	0.0234	0.0207	0.0189	
			20%	Wi	ind idth	0.0518	0.0478	0.0424	0.0388	
					cessing e (ms)	/	/	1342972	1392321	
				Appro	ximate	572356	859792	39232	32323	
				Total Ap	Time (ms) Total Approximate		859792	1382204	1424644	
					e (ms) PI	572356 61.8496	41.1727	25.6113	24.8483	
				Approximate fitness	Lower Bound	0.9618	0.9629	0.9688	0.9702	
					Approximate	0.9809	0.9814	0.9844	0.9851	
					fitness Upper	1.0000	1.0000	1.0000	1.0000	
				Approx	Bound					
				Error Band		0.0186	0.0181	0.0151	0.0144	
			30%	Width		0.0382	0.0371	0.0312	0.0298	
DDIG2012	0.0005	25400000		Preprocessing Time (ms)		/	/	1423219	1529312	
BPIC2012	0.9995	35400000		Approximate Time (ms)		702244	1186892	41992	42223	
				Total Approximate		702244	1186892	1465211	1571535	
					e (ms) PI	50.4098	29.8258	24.1603	22.5257	
					Lower Bound	0.9681	0.9690	0.9756	0.9730	
				Approximate	Approximate	0.9841	0.9845	0.9878	0.9865	
				fitness	fitness Upper	1.0000	1.0000	1.0000	1.0000	
				Approx	Bound	0.0155				
				Er	Error Band		0.0150	0.0117	0.0130	
			40%	Wi	idth	0.0319	0.0310	0.0244	0.0270	
				Time	cessing e (ms)	/	/	1591211	1730030	
					ximate e (ms)	1229401	1480757	41503	49020	
				Total App	proximate	1229401	1480757	1632714	1779050	
					e (ms) PI	28.7945	23.9067	21.6817	19.8983	
					Lower Bound	0.9745	0.9752	0.9802	0.9888	
				Approximate fitness	Approximate fitness	0.9873	0.9876	0.9901	0.9944	
					Upper	1.0000	1.0000	1.0000	1.0000	
					Bound	0.0123	0.0119	0.0094	0.0051	
					ror and					
			50%	Wi	idth	0.0255	0.0248	0.0198	0.0112	
				Time	cessing e (ms)	/	/	1823900	2102097	
				Time	ximate e (ms)	1863573	1971131	42826	43503	
				Total App	proximate e (ms)	1863573	1971131	1866726	2145600	
					PI	18.9958	17.9592	18.9637	16.4989	

	1		1	1			Approxima	tion Method	e ?? continued.
Log	Actual	Normal Alignment	Candidate	Dara	meter	Bas	eline	In-cluste	
Log	Fitness	Time	Percentage	i arameter		Frequency	K-Medoids	In-cluster frequency	In-cluster medoid
					Lower Bound	0.9559	0.9025	0.9610	0.9560
				Approximate fitness	Approximate fitness	0.9780	0.9513	0.9805	0.9780
					Upper Bound	1.0000	1.0000	1.0000	1.0000
					timation tor	0.0218	0.0485	0.0192	0.0217
			10%	Ba	and	0.0441	0.0975	0.0390	0.0440
			10%	Prepro	idth cessing	/	/	69233	70923
				Appro	e (ms) ximate	4200	19572	2033	2992
					e (ms) proximate	4200	19572	71266	73915
					e (ms) PI	32.2381	6.9180	1.8999	1.8318
					Lower Bound	0.9719	0.9422	0.9788	0.9750
				Approximate fitness	Approximate fitness	0.9860	0.9711	0.9894	0.9875
				nuicas	Upper	1.0000	1.0000	1.0000	1.0000
					Bound	0.0138	0.0286	0.0103	0.0122
				Ba	nd	0.0281	0.0578	0.0212	0.0250
			20%	Prepro	idth cessing				79232
					e (ms)	/	/	78012	
					e (ms) proximate	11426	23054	2932	3111
				Time	e (ms) PI	11426	23054 5.8732	80944	82343
					Lower	0.9795	0.9554	0.9860	0.9810
		0.9997 135400	30%	Approximate	Bound Approximate	0.9898	0.9777	0.9930	0.9905
				fitness	fitness Upper	1.0000	1.0000	1.0000	1.0000
					Bound	0.0100	0.0220	0.0067	0.0092
				Error Band					
				Width Preprocessing		0.0205	0.0446	0.0140	0.0190
BPIC2013-incident	0.9997			Time (ms) Approximate		/	/	81203	85003
				Time (ms) Total Approximate		17294	27553	3504	4092
				Time (ms)		17294 7.8293	27553 4.9142	84707	89095
				1	Lower	0.9839	0.9612	0.9902	0.9850
				Approximate	Bound Approximate	0.9920	0.9806	0.9951	0.9925
				fitness	fitness Upper	1.0000	1.0000	1.0000	1.0000
					Bound	0.0078	0.0191	0.0046	0.0072
				Error Band		0.0161	0.0388	0.0040	0.0072
			40%	Width Preprocessing					
				Time	e (ms)	/	/	89129	91892
				Time	e (ms) proximate	27133	32868	3932	3902
				Time	e (ms) PI	27133 4.9902	32868 4.1195	93061	95794
				1	Lower	4.9902 0.9875	0.9825	0.9920	1.4134 0.9879
				Approximate	Bound Approximate	0.9938	0.9913	0.9960	0.9940
				fitness	fitness Upper	1.0000	1.0000	1.0000	1.0000
					Bound	0.0060	0.0085	0.0037	0.0058
				Er Ba	ror and				
			50%	Wi Prepro	idth cessing	0.0125	0.0175	0.0080	0.0121
				Time	e (ms) ximate	/	/	95002	104023
				Time	e (ms) proximate	34006	41028	4002	4350
				Time	e (ms)	34006	41028	99004	108373
				1	Ы	3.9817	3.3002	1.3676	1.2494

		Normal Alignment	Candidate			Table ?? continued. Approximation Method			
Log	Actual			Para	Parameter		eline	In-cluste	r medoid
Log	Fitness	Time	Percentage		-	Frequency	K-Medoids	In-cluster frequency	In-cluster medoid
				Approximate fitness	Lower Bound	0.9679	0.8867	0.9680	0.8911
					Approximate fitness	0.9840	0.9434	0.9840	0.9455
			10%		Upper Bound	1.0000	1.0000	0.9999	0.9999
					imation	0.0158	0.0564	0.0158	0.0542
				Error Band		0.0321	0.1133	0.0319	0.1088
				Width Preprocessing		/	/	359923	389454
				Time(ms) Approximate		47607	61807	2715	1551
				Time(ms) Total Approximate					
				Time(ms) PI		47607 109.2421	61807 84.1440	362638	391005 13.3008
					Lower	0.9845	0.8925	0.9888	0.9130
				Approximate	Bound Approximate	0.9923	0.9463	0.9944	0.9565
				fitness	fitness Upper	1.0000	1.0000	1.0000	1.0000
				Approx	Bound				
				Error Band		0.0074	0.0535	0.0053	0.0432
			20%	Wi	idth	0.0155	0.1075	0.0112	0.0870
		5200690		Preprocessing Time(ms)		/	/	390239	421292
				Approximate Time(ms)		114727	170665	3832	4902
				Total Approximate Time(ms)		114727	170665	394071	426194
				I	PI Lower	45.3310	30.4731	13.1973	12.2026
	0.9997		30%	Approximate fitness	Bound Approximate	0.9874	0.9087	0.9920	0.9309
					fitness	0.9937	0.9544	0.9960	0.9655
					Upper Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0060	0.0454	0.0037	0.0343
				Band Width		0.0126	0.0913	0.0080	0.0691
				Preprocessing Time(ms)		/	/	448922	489322
BPIC2016-Questions				Approximate Time(ms)		176359	266266	6020	6334
				Total Approximate Time(ms)		176359	266266	454942	495656
					Ы	29.4892	19.5319	11.4315	10.4925
			40%		Lower Bound	0.9896	0.9114	0.9940	0.9440
				Approximate fitness	Approximate fitness	0.9948	0.9557	0.9970	0.9720
					Upper Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0049	0.0440	0.0027	0.0277
				Band Width		0.0104	0.0886	0.0060	0.0560
				Preprocessing		/	/	483200	530239
				Time(ms) Approximate		280456	325313	9910	10355
				Time(ms) Total Approximate		280456	325313	493110	540594
					e(ms) PI	18.5437	15.9867	10.5467	9.6203
			50%	Approximate fitness	Lower Bound	0.9913	0.9294	0.9960	0.9503
					Approximate fitness	0.9957	0.9647	0.9980	0.9752
					Upper Bound	1.0000	1.0000	1.0000	1.0000
				Approximation		0.0060	0.0085	0.0037	0.0058
				Error Band		0.0125	0.0175	0.0080	0.0121
				Width Preprocessing		/		566660	602030
				Time(ms) Approximate			/		
				Time(ms) Total Approximate		395799	445163	15330	14340
				Tim	e(ms)	395799 13.1397	445163 11.6827	581990 8.9360	616370 8.4376
			L	PI		15.1597	11.0627	0.7300	0.4370

Table ?? continued. Approximation Method Normal Baseline In-cluster medoid Actual Candidate Log Alignment Time Parameter In-cluster In-cluster Fitness Percentage K-Medoids Frequency frequency medoid Lower Bound Approxima 0.9332 0.9381 0.9454 0.9450 Approximate fitness 0.9726 0.9725 0.9666 0.9691 fitness Upper 1.0000 1.0000 0.9997 1.0000 Bound Approximation Approximation Error Band Width Preprocessing Time (ms) 0.0329 0.0305 0.0270 0.0270 0.0668 0.0619 0.0543 0.0550 10% 86490212 87983292 1 / Approximate 4049416 4399280 400366 509232 Time (ms) Total Approximate Time (ms) PI 4049416 4399280 86890578 88492524 44.6556 41.1043 2.0811 2.0434 Lower 0.9380 0.9399 0.9497 0.9493 Bound Approximate Approximate fitness 0.9690 0.9700 0.9749 0.9747 fitness Upper Bound 1.0000 1.0000 1.0000 1.0000 Approxima Error Band on 0.0305 0.0296 0.0247 0.0249 0.0620 0.0601 0.0503 0.0507 20% Width Preprocessing 91423432 95431122 1 1 Time(ms) Time(ms) Approximate Time(ms) Total Approximate Time(ms) PI 15255832 18597920 424210 561543 15255832 18597920 91847642 95992665 11.8531 9.7231 1.9688 1.8838 Lower 0.9512 0.9431 0.9420 0.9510 Bound Approximate fitness Approximate fitness 0.9715 0.9710 0.9755 0.9756 Upper Bound 1.0000 1.0000 1.0000 1.0000 Approxima Error Band 0.0280 0.0285 0.0240 0.0239 0.0569 0.0580 0.0488 0.0490 30% Width Preprocessing 1 1 95294232 99874342 Time(ms) Approximate Time(ms) Total Approximate BPIC2017 0.9995 180829300 13089388 16606568 502321 424931 13089388 16606568 95796553 100299273 Time(ms) 10.8890 13.8150 1.8029 1.8876 PI Lower 0.9481 0.9480 0.9575 0.9564 Bound Approxim fitness Upper Approximate fitness 0.9741 0.9740 0.9788 0.9782 1.0000 1.0000 1.0000 1.0000 Bound Approximation 0.0255 0.0255 0.0213 0.0208 Error Band 40% 0.0519 0.0520 0.0425 0.0436 Width Preprocessing Time(ms) Approximate 99034313 100293122 16294010 18807577 582312 510124 Time(ms) Total Approximate 16294010 18807577 99616625 100803246 Time(ms) 11.0979 9.6147 1.8153 1.7939 Lower Bound Approximate 0.9528 0.9527 0.9682 0.9691 Approximate fitness 0.9764 0.9764 0.9841 0.9846 fitness Upper 1.0000 1.0000 1.0000 1.0000 Approximation Approximation Error Band Width Preprocessing Time(ms) Approximate Time(ms) 0.0231 0.0232 0.0154 0.0150 0.0472 0.0473 0.0318 0.0309 50% 108224313 119901232 1 20183838 22539508 391222 454002 Total Approximate Time(ms) PI 120355234 20183838 22539508 108615535 8.9591 8.0228 1.6649 1.5025

		Na					Approxima	tion Method	e ?? continued.
Log	Actual	Normal Alignment Time	Candidate Percentage	Parameter		Bas	eline	In-cluste	r medoid
8	Fitness				raianietei		K-Medoids	In-cluster frequency	In-cluster medoid
					Lower Bound	0.9987	0.9975	0.9989	0.9980
				Approximate	Approximate	0.9994	0.9988	0.9993	0.9990
				fitness	fitness Upper				
					Bound	1.0000	1.0000	0.9997	1.0000
			10%	Approximation Error		0.0006	0.0011	0.0006	0.0009
				Band Width		0.0013	0.0025	0.0008	0.0020
				Preprocessing		/	/	10585	11021
				Time(ms) Approximate		8986	15555	2901	3531
				Time(ms) Total Approximate					
				Time(ms)		8986	15555	13486	14552
				1	PI Lower	14.5148	8.3851	9.6715	8.9630
					Bound	0.9994	0.9991	0.9994	0.9990
				Approximate fitness	Approximate fitness	0.9997	0.9996	0.9997	0.9995
					Upper Bound	1.0000	1.0000	1.0000	1.0000
					imation	0.0002	0.0004	0.0002	0.0004
				Ba	ror ind				
			20%	Width		0.0006	0.0009	0.0006	0.0010
				Preprocessing Time(ms)		/	/	14012	15432
				Approximate Time(ms)		8296	11123	3221	3834
				Total Approximate Time(ms)		8296	11123	17233	19266
					e(ms) PI	15.7220	11.7262	7.5686	6.7700
					Lower Bound	0.9994	0.9992	0.9994	0.9994
			30%	Approximate fitness	Approximate	0.9997	0.9996	0.9997	0.9997
					fitness Upper				
					Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0002	0.0003	0.0002	0.0002
				Band Width		0.0006	0.0008	0.0006	0.0006
				Preprocessing		/	/	15236	22293
RTFMP	0.9999	130430		Time(ms) Approximate					
				Time(ms) Total Approximate		9831	10222	3232	3923
				Time	e(ms)	9831	10222	18468	26216
				Approximate fitness	PI Lower	13.2672	12.7597	7.0625	4.9752
			40%		Bound	0.9996	0.9993	0.9998	0.9996
					Approximate fitness	0.9998	0.9997	0.9999	0.9998
					Upper Bound	1.0000	1.0000	1.0000	1.0000
				Approximation		0.0001	0.0003	0.0000	0.0001
				Error Band					0.0004
				Width Preprocessing		0.0004	0.0007	0.0002	
				Time(ms)		/	/	17222	24422
					ximate e(ms)	10323	13123	4442	4232
				Total Approximate		10323	13123	21664	28654
					e(ms) PI	12.6349	9.9390	6.0206	4.5519
			50%	Approximate fitness	Lower Bound	0.9998	0.9996	0.9998	0.9997
					Approximate	0.9999	0.9998	0.9999	0.9999
					fitness Upper				
				A	Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0000	0.0001	0.0000	0.0000
				Band Width		0.0002	0.0004	0.0002	0.0003
				Preprocessing		/	/	19203	30020
				Time(ms) Approximate					
				Time(ms)		9050	10212	4301	5021
				Total Approximate Time(ms)		9050	10212	23504	35041
				PI		14.4122	12.7722	5.5493	3.7222

			1				Approxima	Table tion Method	e ?? continued.
Log	Actual	Normal Alignment Time	Candidate Percentage	Parameter		Baseline		In-cluste	r medoid
	Fitness					Frequency	K-Medoids	In-cluster frequency	In-cluster medoid
					Lower Bound	0.7959	0.7965	0.8204	0.8100
				Approximate fitness	Approximate fitness	0.8980	0.8983	0.9101	0.9050
			10%	ntness	Upper Bound	1.0000	1.0000	0.9997	1.0000
					imation	0.0901	0.0898	0.0780	0.0830
				Error Band		0.2041	0.2035		
				Width Preprocessing				0.1793	0.1900
				Time(ms) Approximate		/	/	107478	110312
				Time(ms)		32599	28302	1902	2032
				Total Approximate Time(ms)		32599	28302	109380	112344
				F	PI Lower	93.1072	107.2433	27.7491	27.0170
					Bound	0.8403	0.8404	0.8626	0.8638
		3035200		Approximate fitness	Approximate fitness	0.9202	0.9202	0.9313	0.9319
			20%		Upper Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0679	0.0678	0.0567	0.0561
				Band Width		0.1597	0.1596	0.1374	0.1362
				Preprocessing Time(ms)		/	/	130101	148903
				Appro	ximate	56803	67461	2303	2289
				Time(ms) Total Approximate		56803	67461	132404	151192
				Time(ms) PI		53.4338	44.9919	22.9238	20.0751
				r	Lower	0.8701	0.8405	0.8730	0.8748
			30%	Approximate fitness	Bound Approximate	0.9351	0.9203	0.9365	0.9374
					fitness Upper				
					Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0530	0.0678	0.0515	0.0506
				Band Width		0.1299	0.1595	0.1270	0.1252
	0.0000			Preprocessing Time(ms)		/	/	159232	162820
Sepsis	0.9880			Approximate Time(ms)		79763	60393	5201	5433
				Total Approximate Time(ms)		79763	60393	164433	168253
					e(ms) PI	38.0527	50.2575	18.4586	18.0395
			40%		Lower Bound	0.8931	0.8959	0.9066	0.9015
				Approximate fitness	Approximate fitness	0.9466	0.9480	0.9533	0.9508
					Upper	1.0000	1.0000	1.0000	1.0000
				Approximation		0.0415	0.0400	0.0347	0.0373
				Error Band		0.1069	0.1041	0.0934	0.0985
				Width Preprocessing					
				Time(ms) Approximate		/	/	182782	209212
				Time(ms)		102649	116824	6123	5736
				Total Approximate Time(ms)		102649	116824	188905	214948
				]	PI Lower	29.5687 0.9112	25.9810 0.9113	16.0673 0.9255	14.1206 0.9192
			50%	Approximate fitness	Bound Approximate				
					fitness Upper	0.9556	0.9557	0.9628	0.9596
					Bound	1.0000	1.0000	1.0000	1.0000
				Approximation Error		0.0324	0.0324	0.0253	0.0284
				Band Width		0.0888	0.0887	0.0745	0.0808
				Preprocessing Time(ms)		/	/	209823	222011
				Approximate		126803	137461	3508	3769
				Time(ms) Total Approximate Time(ms)					
				Total Ap	proximate	126803	137461	213331	225780